

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner	<i>Quyen P. Leung</i>	<i>QPL 4-04</i>	Art Unit 2828	Page 1 of 1

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*	C	US-6,359,330	03-2002	Goudard, Jean-Luc	257/678
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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